



**General Description**

The AO6604 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

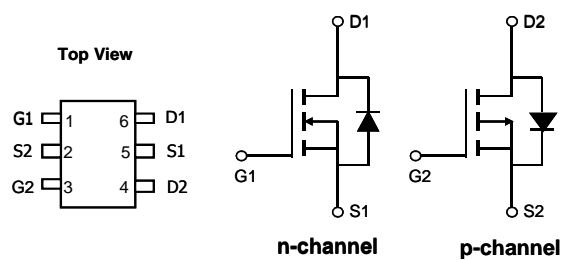
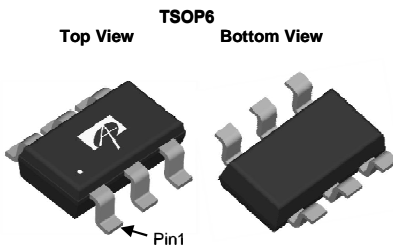
**Product Summary**

**N-Channel**

$V_{DS} = 20V$   
 $I_D = 3.4A$  ( $V_{GS} = 4.5V$ )  
 $R_{DS(ON)} < 65m\Omega$  ( $V_{GS} = 4.5V$ )  
 $< 75m\Omega$  ( $V_{GS} = 2.5V$ )  
 $< 100m\Omega$  ( $V_{GS} = 1.8V$ )

**P-Channel**

$-20V$   
 $-2.5A$  ( $V_{GS} = -4.5V$ )  
 $R_{DS(ON)} < 75m\Omega$  ( $V_{GS} = -4.5V$ )  
 $< 95m\Omega$  ( $V_{GS} = -2.5V$ )  
 $< 115m\Omega$  ( $V_{GS} = -1.8V$ )



**Absolute Maximum Ratings  $T_A = 25^\circ C$  unless otherwise noted**

| Parameter                              | Symbol         | Max n-channel      | Max p-channel | Units      |
|----------------------------------------|----------------|--------------------|---------------|------------|
| Drain-Source Voltage                   | $V_{DS}$       | 20                 | -20           | V          |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 8$            | $\pm 8$       | V          |
| Continuous Drain Current               | $I_D$          | $T_A = 25^\circ C$ | 3.4           | -2.5       |
|                                        |                | $T_A = 70^\circ C$ | 2.5           | -2         |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | 13                 | -13           | A          |
| Power Dissipation <sup>B</sup>         | $P_D$          | $T_A = 25^\circ C$ | 1.1           | 1.1        |
|                                        |                | $T_A = 70^\circ C$ | 0.7           | 0.7        |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150         |               | $^\circ C$ |

**Thermal Characteristics**

| Parameter                                  | Symbol          | Typ | Max | Units        |
|--------------------------------------------|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 78  | 110 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 106 | 150 | $^\circ C/W$ |
| Maximum Junction-to-Lead                   | $R_{\theta JL}$ | 64  | 80  | $^\circ C/W$ |

**N-Channel Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                | Min | Typ      | Max      | Units |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------------|-----|----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                           |     |          |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                | 20  |          |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =20V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |          | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±8V                                                |     |          | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                    | 0.4 | 0.7      | 1        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =5V                                                | 13  |          |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =4.5V, I <sub>D</sub> =3.4A<br>T <sub>J</sub> =125°C                      |     | 51<br>68 | 65<br>85 | mΩ    |
|                             |                                       | V <sub>GS</sub> =2.5V, I <sub>D</sub> =3A                                                 |     | 58       | 75       | mΩ    |
|                             |                                       | V <sub>GS</sub> =1.8V, I <sub>D</sub> =2A                                                 |     | 68       | 100      | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =3.4A                                                 |     | 16       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                   |     | 0.7      | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                           |     |          | 1.5      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                           |     |          |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =10V, f=1MHz                                         | 205 | 260      | 320      | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                           | 33  | 48       | 63       | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |                                                                                           | 16  | 27       | 38       | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                          | 1.5 | 3        | 4.5      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                           |     |          |          |       |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =10V, I <sub>D</sub> =3.4A                         |     | 2.9      | 3.8      | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                           | 0.4 |          | nC       |       |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                           | 0.6 |          | nC       |       |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =5V, V <sub>DS</sub> =10V, R <sub>L</sub> =2.95Ω,<br>R <sub>GEN</sub> =3Ω |     | 2.5      |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                           | 3.2 |          | ns       |       |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                           | 21  |          | ns       |       |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                           | 3   |          | ns       |       |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =3.4A, dI/dt=100A/μs                                                       |     | 14       | 19       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =3.4A, dI/dt=100A/μs                                                       |     | 3.8      |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

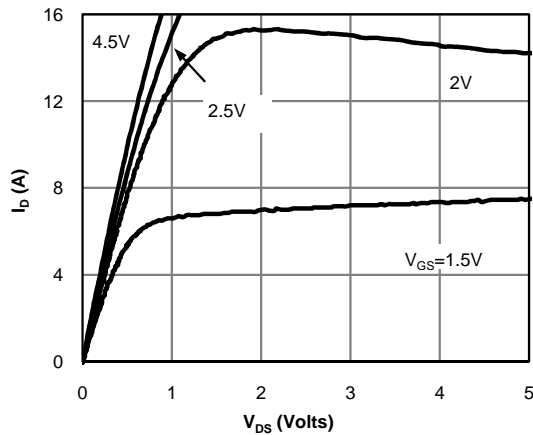
D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

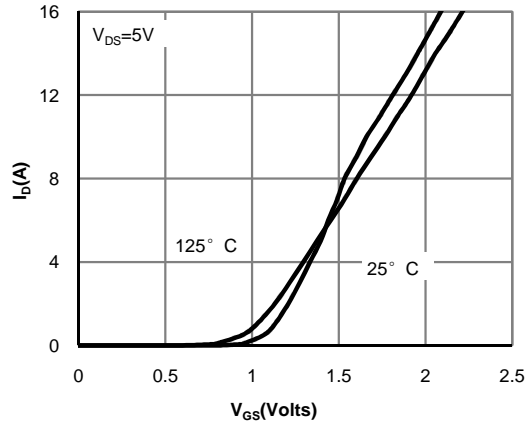
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

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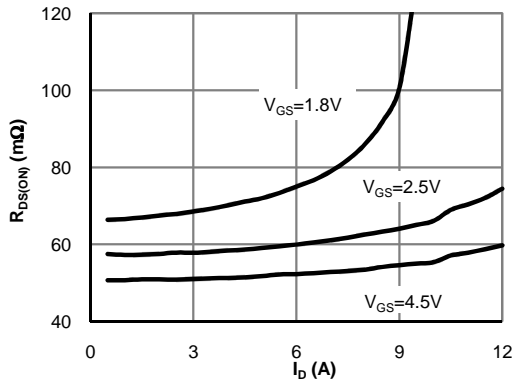
**N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



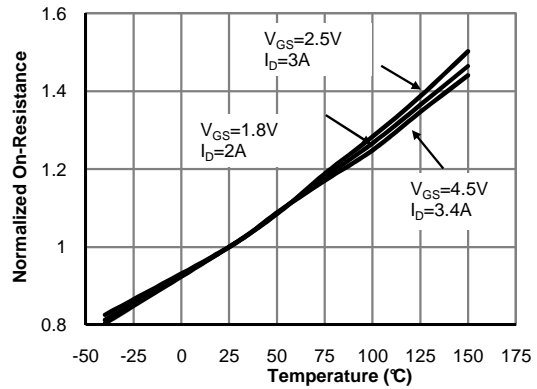
**Fig 1: On-Region Characteristics (Note E)**



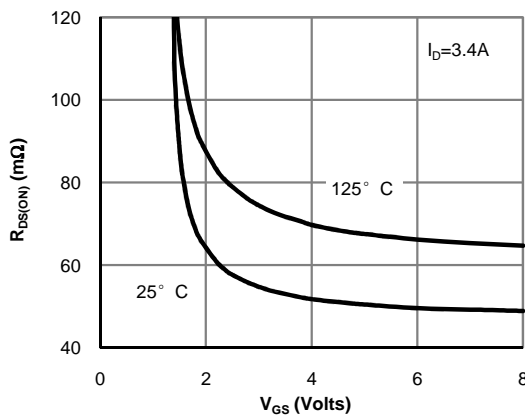
**Figure 2: Transfer Characteristics (Note E)**



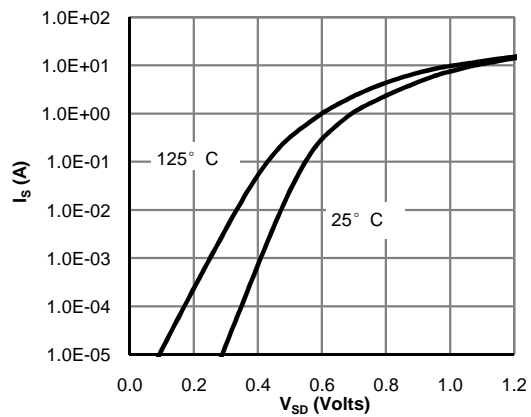
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

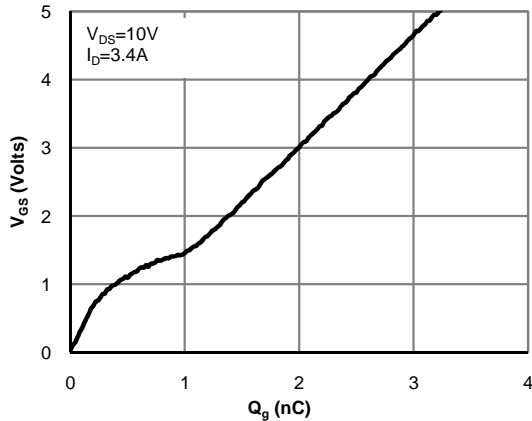


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

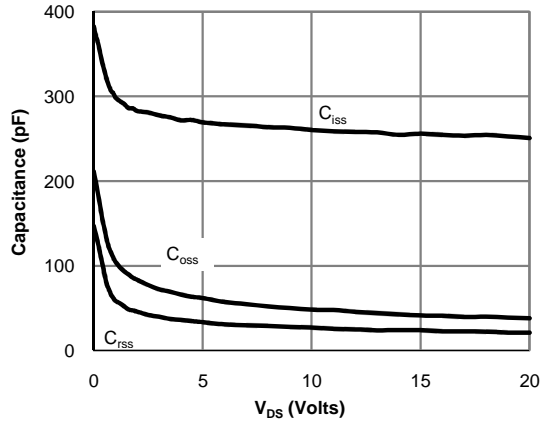


**Figure 6: Body-Diode Characteristics (Note E)**

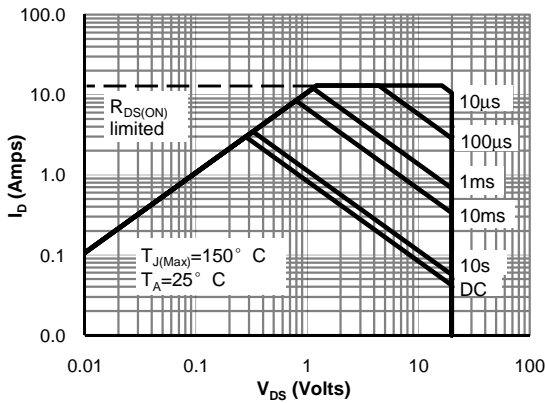
**N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



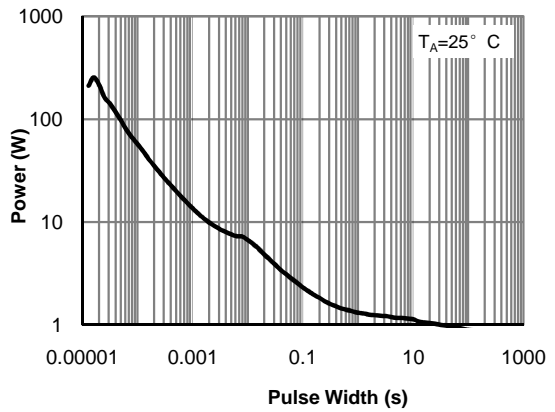
**Figure 7: Gate-Charge Characteristics**



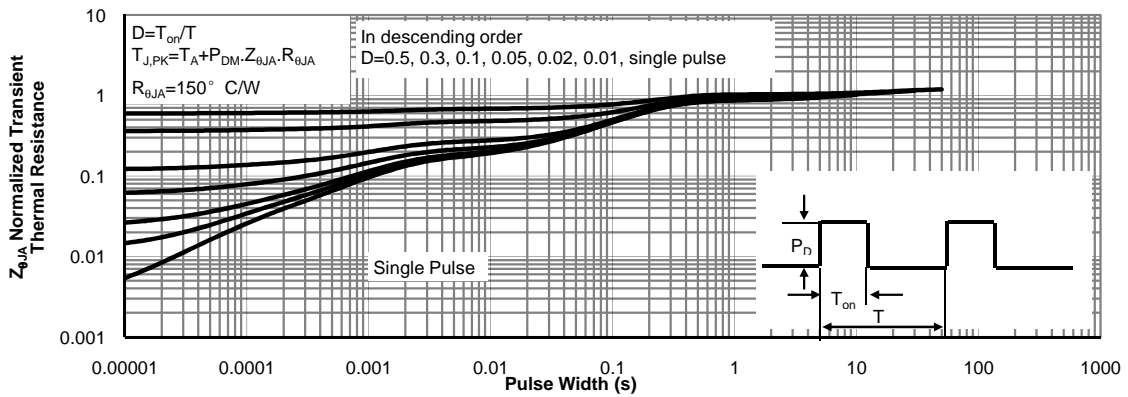
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

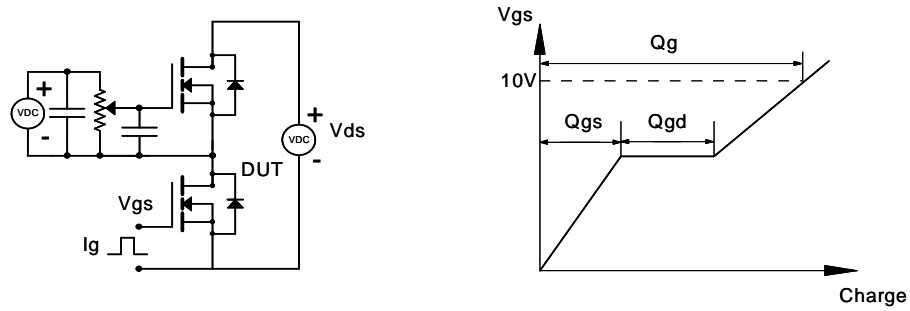


**Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)**

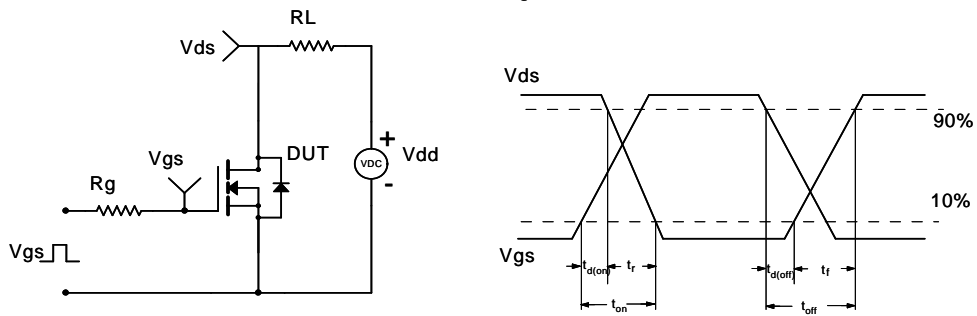


**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

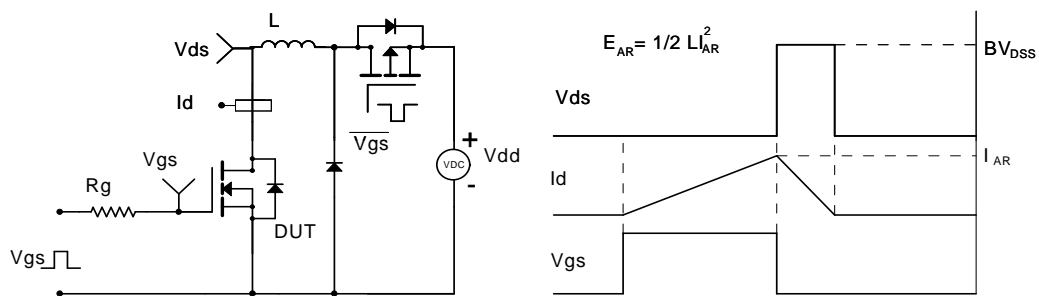
**Gate Charge Test Circuit & Waveform**



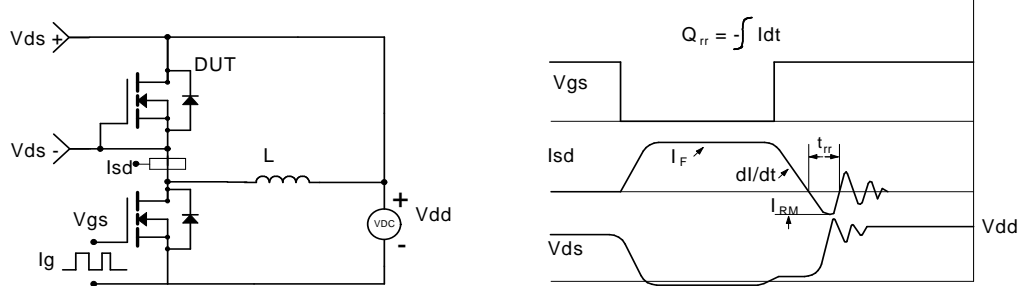
**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**



**Diode Recovery Test Circuit & Waveforms**



**P-Channel Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                 | Min  | Typ      | Max       | Units |
|-----------------------------|---------------------------------------|--------------------------------------------------------------------------------------------|------|----------|-----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                            |      |          |           |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V                                                | -20  |          |           | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |      |          | -1<br>-5  | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±8V                                                 |      |          | ±100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA                                  | -0.4 | -0.65    | -1        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-5V                                               | -13  |          |           | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2.5A<br>T <sub>J</sub> =125°C                     |      | 56<br>80 | 75<br>105 | mΩ    |
|                             |                                       | V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-2A                                                |      | 70       | 95        | mΩ    |
|                             |                                       | V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-1A                                                |      | 85       | 115       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-2.5A                                                |      | 13       |           | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V                                                   |      | -0.7     | -1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                            |      |          | -1.5      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                            |      |          |           |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =-10V, f=1MHz                                         |      | 560      | 745       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                            |      | 80       |           | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |                                                                                            |      | 70       |           | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                           |      | 15       | 23        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                            |      |          |           |       |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-10V, I <sub>D</sub> =-2.5A                       |      | 8.5      | 11        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                            |      | 1.2      |           | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                            |      | 2.1      |           | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-10V, R <sub>L</sub> =4Ω,<br>R <sub>GEN</sub> =6Ω |      | 7.2      |           | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                            |      | 36       |           | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                            |      | 53       |           | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                            |      | 56       |           | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-2.5A, dI/dt=100A/μs                                                       |      | 37       | 49        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-2.5A, dI/dt=100A/μs                                                       |      | 27       |           | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

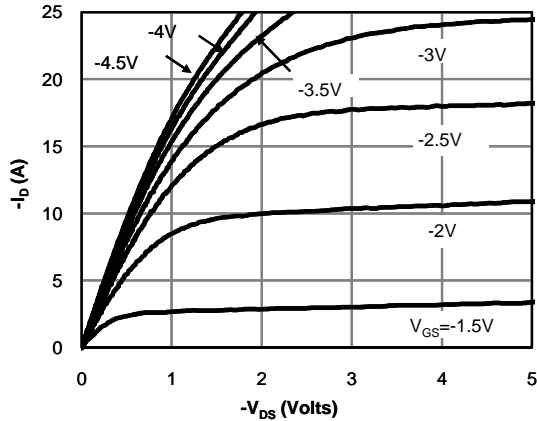
D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

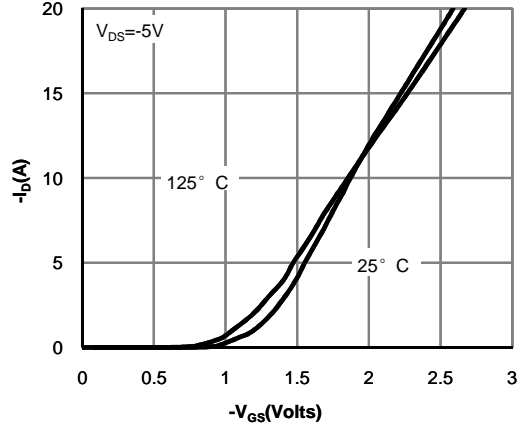
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

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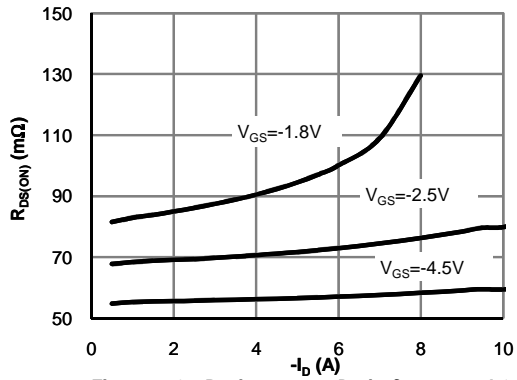
**P-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



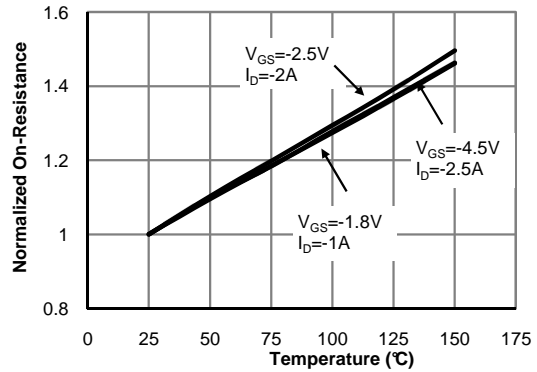
**Fig 1: On-Region Characteristics (Note E)**



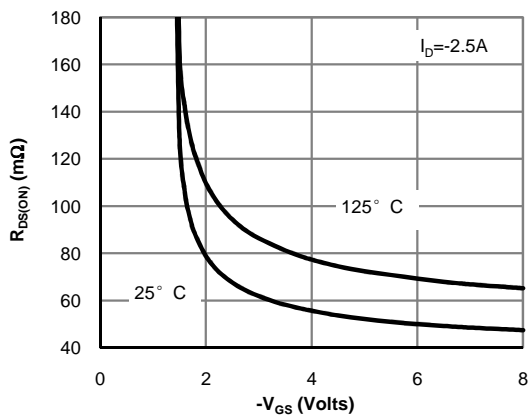
**Figure 2: Transfer Characteristics (Note E)**



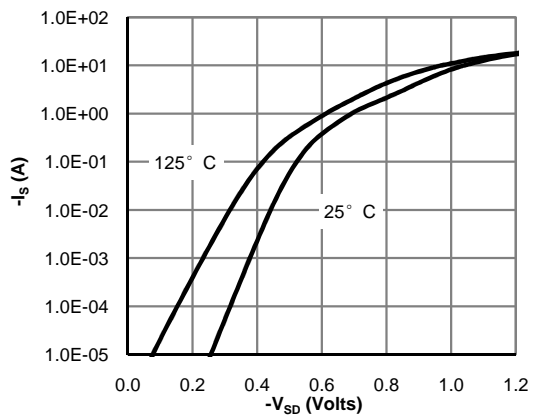
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**



**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**



**Figure 6: Body-Diode Characteristics (Note E)**

**P-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

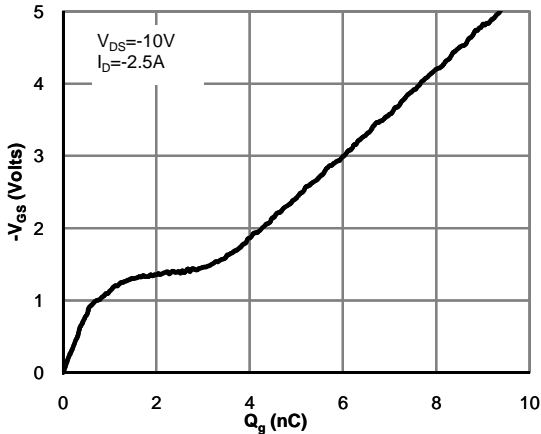


Figure 7: Gate-Charge Characteristics

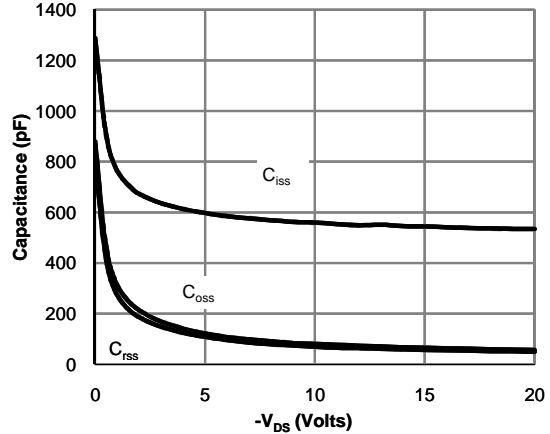


Figure 8: Capacitance Characteristics

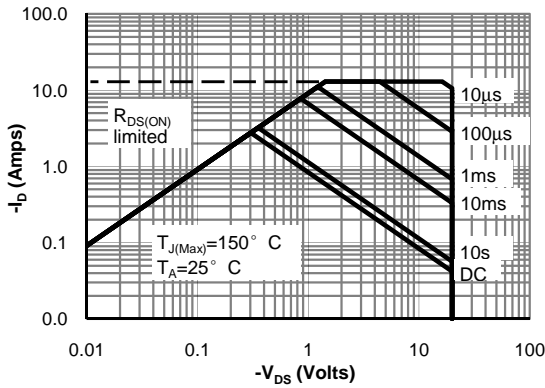


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

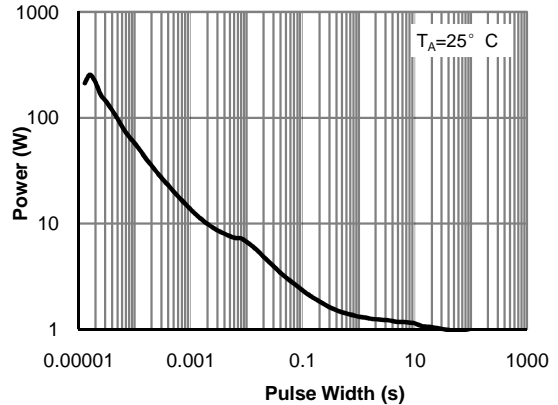


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

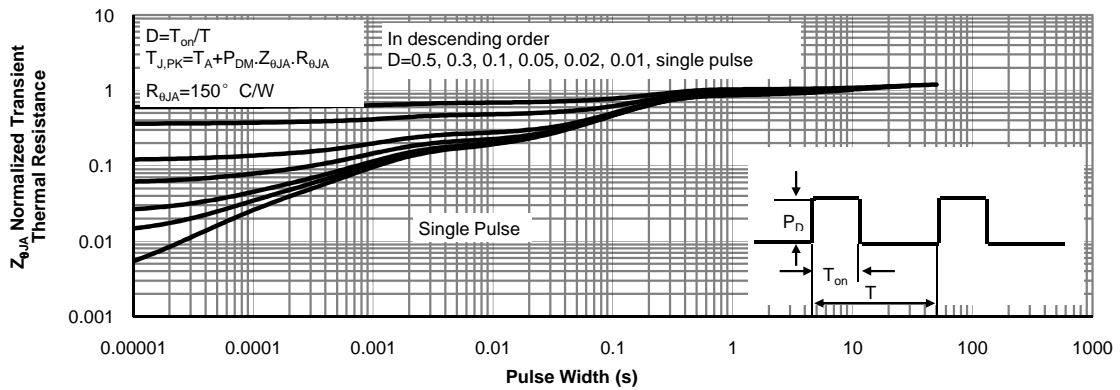
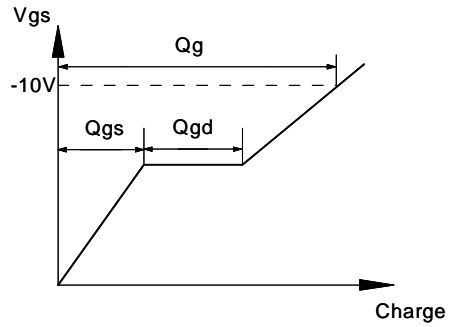
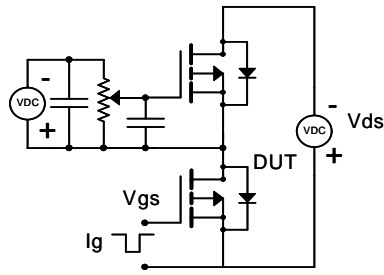


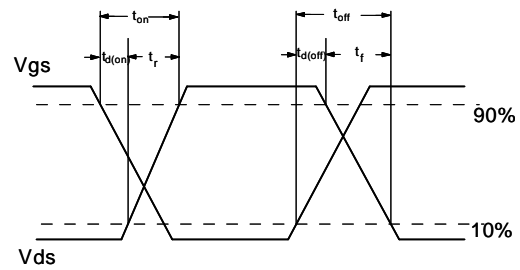
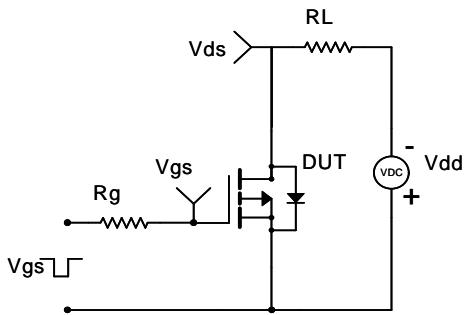
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



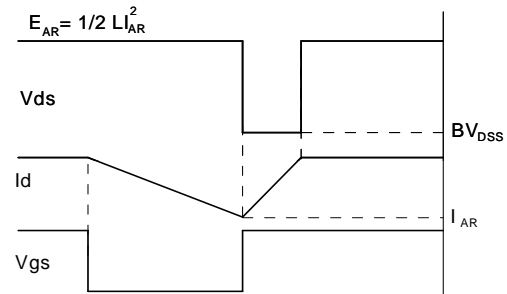
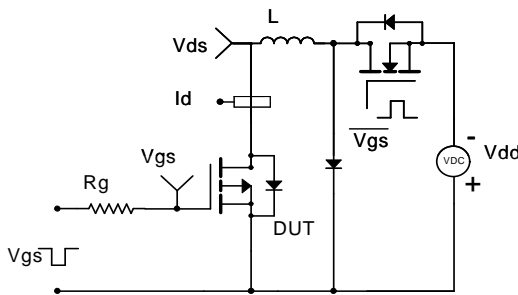
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

